

### AP9575GH-HF-VB Datasheet

## P-Channel 60-V (D-S) MOSFET

| PRODUCT SUMMARY     |  |                    |                      |  |  |
|---------------------|--|--------------------|----------------------|--|--|
| V <sub>DS</sub> (V) | <b>R<sub>DS(on)</sub> (</b> Ω <b>)</b> | I <sub>D</sub> (A) | Q <sub>g</sub> (Typ) |  |  |
| - 60                | 0.061 at V <sub>GS</sub> = - 10 V      | - 30               | 10                   |  |  |
| - 60                | 0.072 at V <sub>GS</sub> = - 4.5 V     | - 25               | 10                   |  |  |

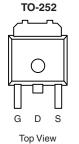
#### FEATURES

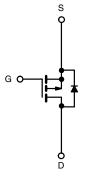
- Trench Power MOSFET
- 100 % UIS Tested

#### **APPLICATIONS**

Load Switch







P-Channel MOSFET

| Parameter  | Symbol                  | Limit                             | Unit            |       |  |
|--|-------------------------|-----------------------------------|-----------------|-------|--|
| Gate-Source Voltage                                | V <sub>GS</sub>         | ± 20                              | V               |       |  |
| Continuous Drain Current ( $T_1 = 175 ^{\circ}C$ ) | T <sub>C</sub> = 25 °C  | 1_                                | - 30            |       |  |
| Continuous Drain Current $(1) = 175$ C)            | T <sub>C</sub> = 100 °C | ID –                              | - 25            |       |  |
| Pulsed Drain Current                               | I <sub>DM</sub>         | - 30                              | А               |       |  |
| Continuing Source Current (Diode Conduction)       | ۱ <sub>S</sub>          | - 20                              |                 |       |  |
| Avalanche Current                                  | I <sub>AS</sub>         | - 20                              | 1               |       |  |
| Single Pulse Avalanche Energy                      | L = 0.1 mH              | E <sub>AS</sub>                   | 7.2             | mJ    |  |
| Maximum Dawar Dissinction                          | T <sub>C</sub> = 25 °C  | В                                 | 34 <sup>a</sup> | w     |  |
| Maximum Power Dissipation                          | T <sub>A</sub> = 25 °C  | P <sub>D</sub>                    | 4 <sup>b</sup>  | ~ ~ ~ |  |
| Operating Junction and Storage Temperature Range   |                         | T <sub>J</sub> , T <sub>stg</sub> | - 55 to 175     | °C    |  |

| THERMAL RESISTANCE RATINGS       |              |                   |         |         |      |  |
|----------------------------------|--------------|-------------------|---------|---------|------|--|
| Parameter                        |              | Symbol            | Typical | Maximum | Unit |  |
| hundling to Anching b            | t ≤ 10 sec   | D                 | 20      | 25      | °C/W |  |
| Junction-to-Ambient <sup>D</sup> | Steady State | R <sub>thJA</sub> | 62      | 75      |      |  |
| Junction-to-Case                 |              | R <sub>thJC</sub> | 5       | 6       |      |  |

Notes:

a. See SOA curve for voltage derating.

b. Surface Mounted on 1" x 1" FR-4 boad.

| <b>SPECIFICATIONS</b> $T_J = 25 \text{ °C}$ , unless otherwise noted |                      |  |       |                  |       |      |  |
|--|----------------------|--|-------|------------------|-------|------|--|
| Parameter  | Symbol               | Test Conditions  | Min   | Typ <sup>a</sup> | Мах   | Unit |  |
| Static   |                      |  |       |                  |       |      |  |
| Drain-Source Breakdown Voltage                                       | V <sub>(BR)DSS</sub> | $V_{GS} = 0 \text{ V}, \text{ I}_{D} = -250 \mu\text{A}$   |       |                  |       | v    |  |
| Gate Threshold Voltage   | V <sub>GS(th)</sub>  | $V_{DS} = V_{GS}$ , $I_D = -250 \ \mu A$   | - 1.0 | - 2.0            | - 3.0 | v    |  |
| Gate-Body Leakage  | I <sub>GSS</sub>     | $V_{DS} = 0 V, V_{GS} = \pm 20 V$  |       |                  | ± 100 | nA   |  |
|  | I <sub>DSS</sub>     | $V_{DS} = -60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$   |       |                  | - 1   |      |  |
| Zero Gate Voltage Drain Current                                      |                      | $V_{DS}$ = - 60 V, $V_{GS}$ = 0 V, $T_{J}$ = 125 °C  |       |                  | - 50  | μΑ   |  |
|  |                      | $V_{DS}$ = - 60 V, $V_{GS}$ = 0 V, $T_{J}$ = 175 °C  |       |                  | - 150 |      |  |
| On-State Drain Current <sup>b</sup>                                  | I <sub>D(on)</sub>   | V <sub>DS</sub> = - 5 V, V <sub>GS</sub> = - 10 V  | - 10  |                  |       | А    |  |
|  |                      | V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 5 A   |       | 0.061            |       |      |  |
|  | -                    | $V_{GS}$ = - 10 V, I <sub>D</sub> = - 5 A, T <sub>J</sub> = 125 °C   |       | 0.100            |       | Ω    |  |
| Drain-Source On-State Resistance <sup>b</sup>                        | <sup>r</sup> DS(on)  | $V_{GS}$ = - 10 V, I <sub>D</sub> = - 5 A, T <sub>J</sub> = 175 °C   |       | 0.150            |       |      |  |
|  |                      | V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 2 A  |       | 0.072            |       |      |  |
| Forward Transconductanceb  | 9 <sub>fs</sub>      | V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 5 A   |       | 8                |       | S    |  |
| Dynamic  | ļ                    |  |       |                  |       |      |  |
| Input Capacitance  | C <sub>iss</sub>     |  |       | 1000             |       | pF   |  |
| Output Capacitance   | C <sub>oss</sub>     | $V_{DS}$ = - 25 V, $V_{GS}$ = 0 V, f = 1 MHz   |       | 120              |       |      |  |
| Reverse Transfer Capacitance   | C <sub>rss</sub>     |  |       | 100              |       |      |  |
| Total Gate Charge  | Qg                   |  |       | 10               |       | nC   |  |
| Gate-Source Charge   | Q <sub>gs</sub>      | $V_{DS} = -30$ V, $V_{GS} = -10$ V, $I_{D} = -8.4$ A   |       | 2.1              |       |      |  |
| Gate-Drain Charge  | Q <sub>gd</sub>      |  |       | 3.2              |       | 1    |  |
| Gate Resistance  | R <sub>g</sub>       | f = 1 MHz  |       | 8.0              |       | Ω    |  |
| Turn-On Delay Time <sup>c</sup>                                      | t <sub>d(on)</sub>   |  |       | 6                |       |      |  |
| Rise Time <sup>c</sup>   | t <sub>r</sub>       | $V_{DD} = -30 \text{ V}, \text{ R}_{L} = 3.57 \Omega$  |       | 15               |       | ns   |  |
| Turn-Off Delay Time <sup>c</sup>                                     | t <sub>d(off)</sub>  | $\text{I}_{\text{D}}\cong$ - 8.4 A, $\text{V}_{\text{GEN}}$ = - 10 V, $\text{R}_{\text{G}}$ = 2.5 $\Omega$ |       | 16               |       |      |  |
| Fall Time <sup>c</sup>   | t <sub>f</sub>       |  |       | 8                |       | 1    |  |
| Source-Drain Diode Ratings and Cha                                   | racteristics         | (T <sub>C</sub> = 25 °C) <sup>b</sup>  |       |                  |       |      |  |
| Pulsed Current   | I <sub>SM</sub>      |  |       |                  | - 30  | А    |  |
| Forward Voltage <sup>b</sup>   | V <sub>SD</sub>      | $I_{F} = -2 \text{ A}, V_{GS} = 0 \text{ V}$   |       | - 0.9            | - 1.3 | V    |  |
| Reverse Recovery Time  | t <sub>rr</sub>      |  |       | 50               |       | ns   |  |
| Reverse Recovery Time  | Q <sub>rr</sub>      | I <sub>F</sub> = - 8 A, di/dt = 100 A/μs   |       | 80               |       | nC   |  |

Notes:

a. Guaranteed by design, not subject to production testing.

b. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

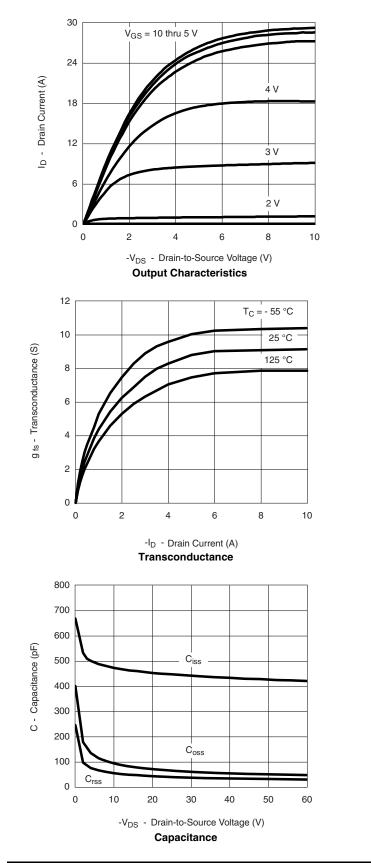
c. Independent of operating temperature.

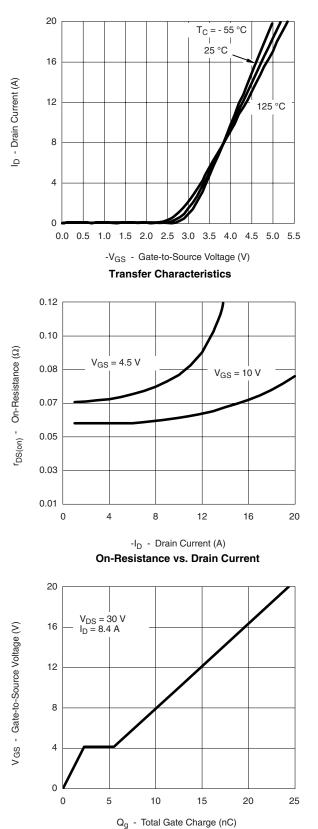
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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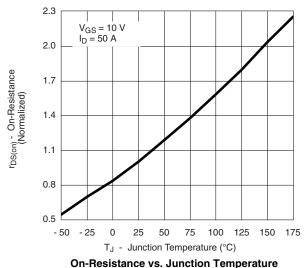


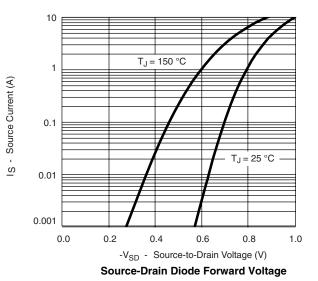




Gate Charge

#### TYPICAL CHARACTERISTICS 25 °C unless noted



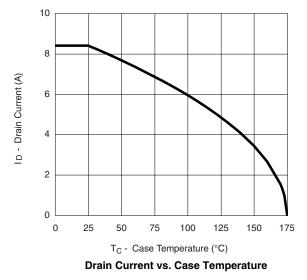


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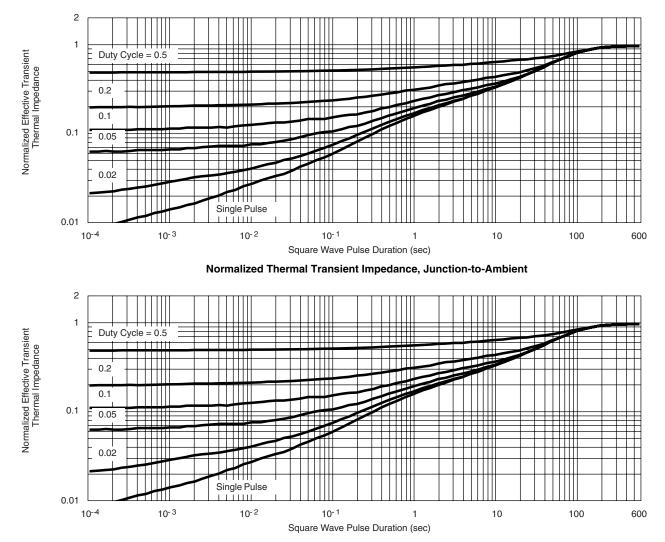
100 10 µs 10\*Limited by <u></u> 100 μs I D - Drain Current (A) TL ms 1 10 ms 100 ms, DC 0.1 T<sub>C</sub> = 25 °C Single Pulse 0.01 Ħ 0.001 0.1 1 10 100 -V\_{DS} - Drain-to-Source Voltage (V)  $^{*}V_{GS}$  > minimum V\_{GS} at which  $r_{DS(\text{on})}$  is specified Safe Operating Area

#### THERMAL RATINGS





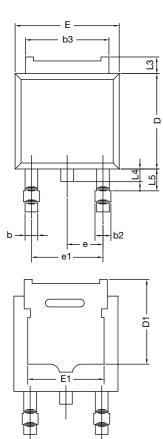
#### THERMAL RATINGS

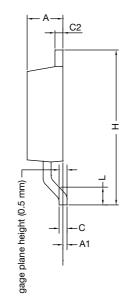


Normalized Thermal Transient Impedance, Junction-to-Case









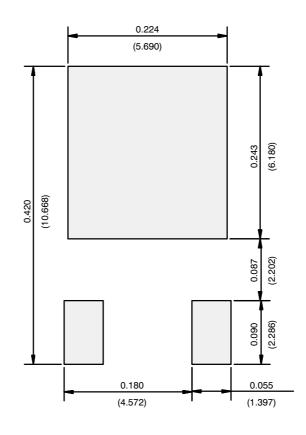
|                         | MILLIN       | IETERS    | INCHES    |       |  |
|-------------------------|--------------|-----------|-----------|-------|--|
| DIM.                    | MIN.         | MAX.      | MIN.      | MAX.  |  |
| А                       | 2.18         | 2.38      | 0.086     | 0.094 |  |
| A1                      | -            | 0.127     | -         | 0.005 |  |
| b                       | 0.64         | 0.88      | 0.025     | 0.035 |  |
| b2                      | 0.76         | 1.14      | 0.030     | 0.045 |  |
| b3                      | 4.95         | 5.46      | 0.195     | 0.215 |  |
| С                       | 0.46         | 0.61      | 0.018     | 0.024 |  |
| C2                      | 0.46         | 0.89      | 0.018     | 0.035 |  |
| D                       | 5.97         | 6.22      | 0.235     | 0.245 |  |
| D1                      | 5.21         | -         | 0.205     | -     |  |
| Е                       | 6.35         | 6.73      | 0.250     | 0.265 |  |
| E1                      | 4.32         | -         | 0.170     | -     |  |
| Н                       | 9.40         | 10.41     | 0.370     | 0.410 |  |
| е                       | 2.28         | BSC       | 0.090 BSC |       |  |
| e1                      | 4.56         | BSC       | 0.180 BSC |       |  |
| L                       | 1.40         | 1.78      | 0.055     | 0.070 |  |
| L3                      | 0.89         | 1.27      | 0.035     | 0.050 |  |
| L4                      | -            | 1.02      | -         | 0.040 |  |
| L5                      | 1.14         | 1.52      | 0.045     | 0.060 |  |
| ECN: X12-(<br>DWG: 5347 | )247-Rev. M, | 24-Dec-12 |           |       |  |

Note

• Dimension L3 is for reference only.



#### **RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)**



Recommended Minimum Pads Dimensions in Inches/(mm)



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